

**Notice of References Cited**

Application/Control No.

10/025,576

Applicant(s)/Patent Under  
Reexamination  
NIWA ET AL.

Examiner

Thomas R. Hannon

Art Unit

3682

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,273,612	08-2001	Ono et al.	384/276
	B	US-6,082,904	07-2000	Ono et al.	384/291
	C	US-5,238,311	08-1993	Katou et al.	384/288
	D	US-3,386,783	06-1968	Scheufler	384/291
	E	US-2,850,334	09-1958	Hurley	384/294
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-03048017 A	03-1991	Japan	Nagumo	384/291
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.